

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China







COMPLIANT

HALOGEN

FREE





PowerPAK ChipFET Dual

Dual P-Channel 30 V (D-S) MOSFET

PRODU	ICT SUMMARY		
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)
- 30	0.054 at V _{GS} = - 10 V	- 6 ^a	4.8 nC
- 30	0.088 at V _{GS} = - 4.5 V	- 6 ^a	4.0110

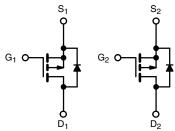
FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- New Thermally Enhanced PowerPAK[®] ChipFET[®] Package
 - Small Footprint Area
 - Low On-Resistance
 - Thin 0.8 mm Profile
- 100 % R_q Tested
- Compliant to RoHS Directive 2002/95/EC



Lot Traceability and Date Code

- Load Switch for Portable Devices
- DC/DC Converters



Part # Code

Marking Code

Ordering Information: Si5997DU-T1-GE3 (Lead (Pb)-free and Halogen-free)

Bottom View

P-Channel MOSFET P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)						
Parameter		Symbol	Limit	Unit		
Drain-Source Voltage		V_{DS}	- 30	V		
Gate-Source Voltage		V_{GS}	± 20	V		
	T _C = 25 °C		- 6 ^a			
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 70 °C	I _D	- 6 ^a			
Continuous Diam Current (1) = 150 C)	T _A = 25 °C		- 5.1 ^{b, c}			
	T _A = 70 °C		- 4.1 ^{b, c}	Α		
Pulsed Drain Current (t = 300 μs)		I _{DM}	- 25			
Continuous Source-Drain Diode Current	T _C = 25 °C	- I _S	- 6 ^a			
Continuous Source-Diam Diode Current	T _A = 25 °C		- 1.9 ^{b, c}			
	T _C = 25 °C		10.4			
Maximum Power Dissipation	$T_C = 70 ^{\circ}C$	P _D	6.7	W		
Maximum i owei Dissipation	T _A = 25 °C		2.3 ^{b, c}	VV		
	T _A = 70 °C		1.5 ^{b, c}			
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature) ^{d, e}			260	O		

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R_{thJA}	43	55	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	9.5	12	0/ **

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. See solder profile (www.vishay.com/ppg?73257). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 105 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	1				'	,
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 30			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050A		- 22		1406
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	- I _D = - 250 μA		4.1		mV/°
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	- 1.2		- 2.4	٧
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
7. 0. 1/1. 5. 0	I _{DSS}	V _{DS} = - 30 V, V _{GS} = 0 V			- 1	μΑ
Zero Gate Voltage Drain Current		V _{DS} = - 30 V, V _{GS} = 0 V, T _J = 55 °C			- 10	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 20			Α
	Б	V _{GS} = - 10 V, I _D = - 3 A		0.045	0.054	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 1 A		0.072	0.088	Ω
Forward Transconductance ^a	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1			7		S
Dynamic ^b	1				'	
Input Capacitance	C _{iss}			430		
Output Capacitance	C _{oss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz		90		pF
Reverse Transfer Capacitance	C _{rss}			70		
Total Oata Observe	0	V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 5.1 A		9.5	14.5	
Total Gate Charge	Qg			4.8	7.5	
Gate-Source Charge	Q_{gs}	V _{DS} = - 15 V, V _{GS} = - 4.5 V, I _D = - 5.1 A		1.6		nC
Gate-Drain Charge	Q_{gd}			2.2		
Gate Resistance	R_{g}	f = 1 MHz	2	8	16	Ω
Turn-On Delay Time	t _{d(on)}			35	70	
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_L = 3.7 \Omega$		25	50	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 4.1 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		17	35	
Fall Time	t _f			10	20	1
Turn-On Delay Time	t _{d(on)}			10	20	ns
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_L = 3.7 \Omega$		10	20	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -4.1 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		20	40	
Fall Time	t _f			10	20	
Drain-Source Body Diode Characteristi	cs				'	
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 6	_
Pulse Diode Forward Current	I _{SM}				- 25	A
Body Diode Voltage	V_{SD}	I _S = - 4.1 A, V _{GS} = 0 V		- 0.85	- 1.2	٧
Body Diode Reverse Recovery Time	t _{rr}			15	30	ns
Body Diode Reverse Recovery Charge	Q _{rr}	l _F = - 4 A, dl/dt = 100 A/μs, T _{.l} = 25 °C		8	15	nC
Reverse Recovery Fall Time	t _a	$1 \text{ if } = -4 \text{ A}, \text{ ui/ut} = 100 \text{ A/}\mu\text{s}, \text{ I}_{J} = 25 ^{\circ}\text{C}$		10.5		
Reverse Recovery Rise Time	t _b	┥ ㅏ		4.5		ns

Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

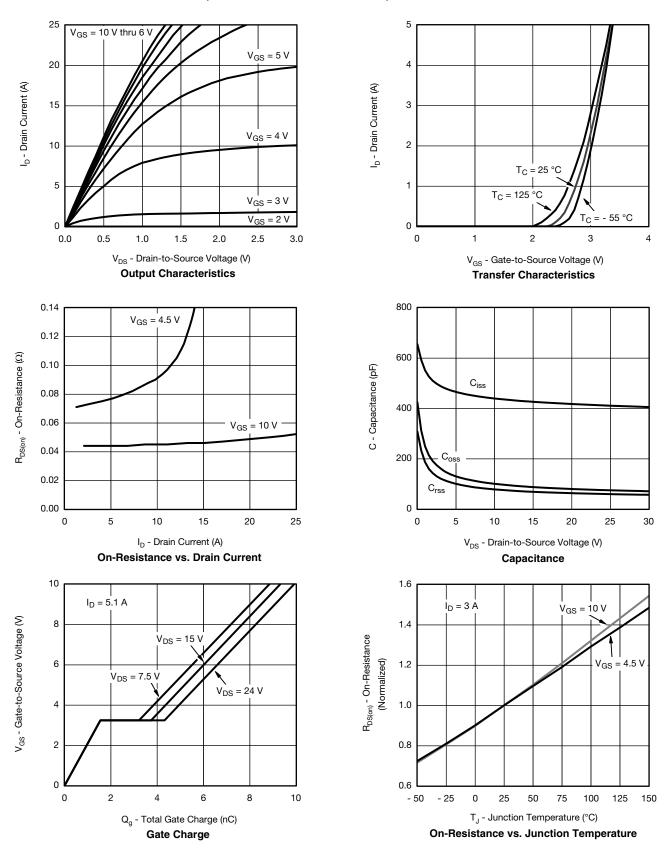
b. Guaranteed by design, not subject to production testing.



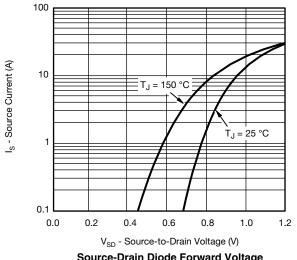


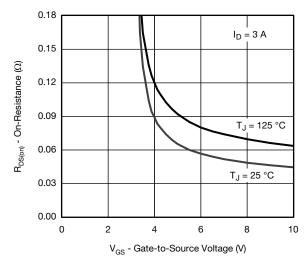


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



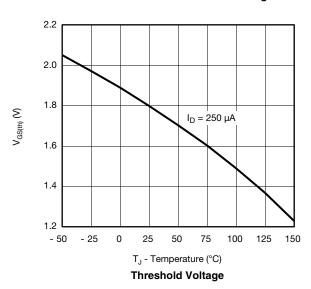
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

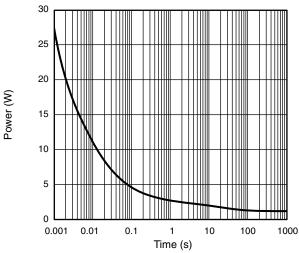




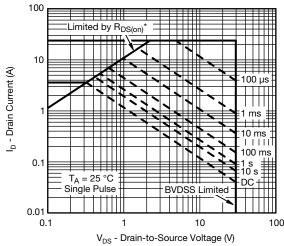
Source-Drain Diode Forward Voltage







Single Pulse Power, Junction-to-Ambient



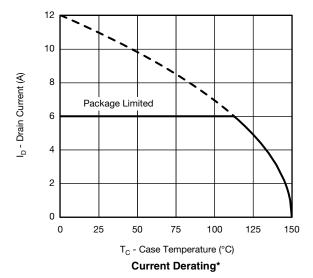
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

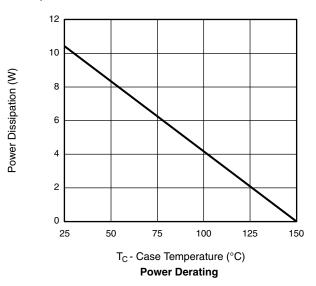
Safe Operating Area, Junction-to-Ambient





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

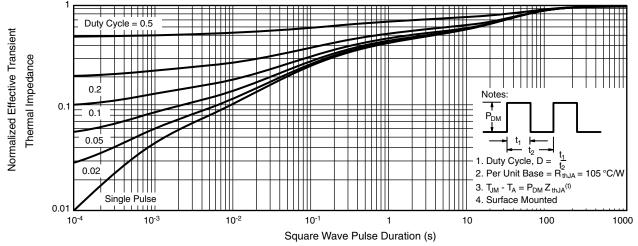




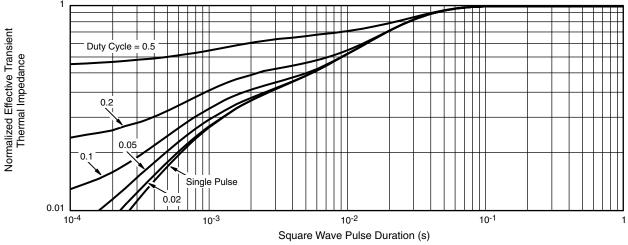
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient

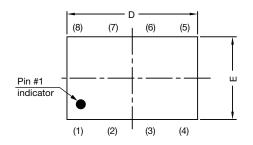


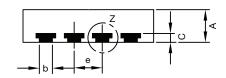
Normalized Thermal Transient Impedance, Junction-to-Case

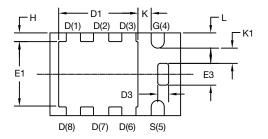
Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg267186.



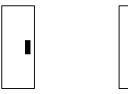
PowerPAK® ChipFET® Case Outline







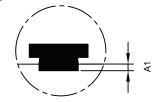
Backside view of single pad



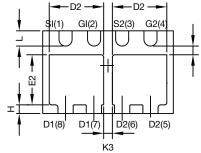
Side view of single



Side view of dual



Detail Z



Backside view of dual pad

DIM.	MILLIMETERS			INCHES				
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.		
Α	0.70	0.75	0.85	0.028	0.030	0.033		
A1	0	-	0.05	0	-	0.002		
b	0.25	0.30	0.35	0.010	0.012	0.014		
С	0.15	0.20	0.25	0.006	0.008	0.010		
D	2.92	3.00	3.08	0.115	0.118	0.121		
D1	1.75	1.87	2.00	0.069	0.074	0.079		
D2	1.07	1.20	1.32	0.042	0.047	0.052		
D3	0.20	0.25	0.30	0.008	0.010	0.012		
Е	1.82	1.90	1.98	0.072	0.075	0.078		
E1	1.38	1.50	1.63	0.054	0.059	0.064		
E2	0.92	1.05	1.17	0.036	0.041	0.046		
E3	0.45	0.50	0.55	0.018	0.020	0.022		
е		0.65 BSC			0.026 BSC			
Н	0.15	0.20	0.25	0.006	0.008	0.010		
K	0.25	-	-	0.010	-	ı		
K1	0.30	-	-	0.012	-	-		
K2	0.20	-	-	0.008	-	-		
K3	0.20	-	-	0.008	-	ı		
L	0.30	0.35	0.40	0.012	0.014	0.016		

C14-0630-Rev. E, 21-Jul-14

DWG: 5940

Note

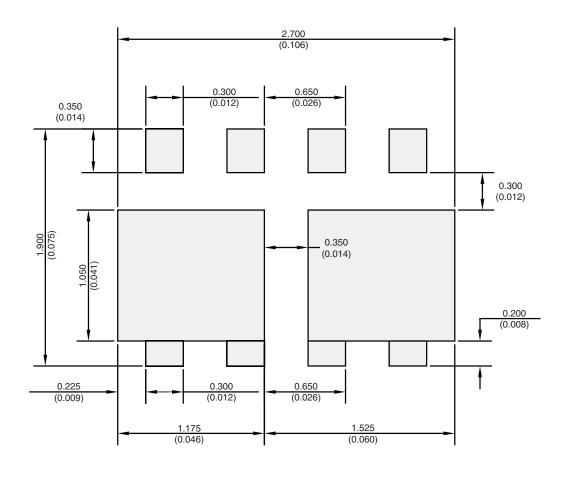
• Millimeters will govern

Revision: 21-Jul-14

APPLICATION NOTE



RECOMMENDED MINIMUM PADS FOR PowerPAK® ChipFET® Dual



Recommended Minimum Pads Dimensions in mm/(Inches)

Note: This is Flipped Mirror Image Pin #1 Location is Top Left Corner

Return to Index



Legal Disclaimer Notice

Vishay

Disclaimer

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product.

Vishay makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Vishay disclaims (i) any and all liability arising out of the application or use of any product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Vishay's knowledge of typical requirements that are often placed on Vishay products in generic applications. Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and / or specifications may vary in different applications and performance may vary over time. All operating parameters, including typical parameters, must be validated for each customer application by the customer's technical experts. Product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein.

Except as expressly indicated in writing, Vishay products are not designed for use in medical, life-saving, or life-sustaining applications or for any other application in which the failure of the Vishay product could result in personal injury or death. Customers using or selling Vishay products not expressly indicated for use in such applications do so at their own risk. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay. Product names and markings noted herein may be trademarks of their respective owners.